

# AON7426

## 30V N-Channel MOSFET

### General Description

The AON7426 combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . This device is ideal for load switch and battery protection applications.

RoHS and Halogen-Free Compliant

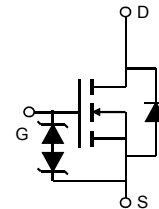
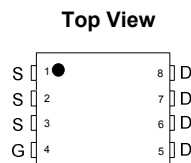
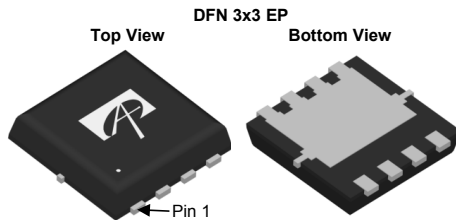
### Product Summary

|                                  |                 |
|----------------------------------|-----------------|
| $V_{DS}$                         | 30V             |
| $I_D$ (at $V_{GS}=10V$ )         | 40A             |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )  | < 5.5m $\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS}=4.5V$ ) | < 8m $\Omega$   |

### Typical ESD protection

100% UIS Tested  
100%  $R_g$  Tested

HBM Class 3A



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                                      | Symbol           | Maximum                 | Units            |
|--|------------------|-------------------------|------------------|
| Drain-Source Voltage                           | $V_{DS}$         | 30                      | V                |
| Gate-Source Voltage                            | $V_{GS}$         | $\pm 20$                | V                |
| Continuous Drain Current <sup>G</sup>          | $I_D$            | $T_C=25^\circ\text{C}$  | 40               |
|  |                  | $T_C=100^\circ\text{C}$ | 31               |
| Pulsed Drain Current <sup>C</sup>              | $I_{DM}$         | 130                     | A                |
| Continuous Drain Current                       | $I_{DSM}$        | $T_A=25^\circ\text{C}$  | 18               |
|  |                  | $T_A=70^\circ\text{C}$  | 14               |
| Avalanche Current <sup>C</sup>                 | $I_{AS}, I_{AR}$ | 35                      | A                |
| Avalanche energy $L=0.1\text{mH}$ <sup>C</sup> | $E_{AS}, E_{AR}$ | 61                      | mJ               |
| Power Dissipation <sup>B</sup>                 | $P_D$            | $T_C=25^\circ\text{C}$  | 29               |
|  |                  | $T_C=100^\circ\text{C}$ | 12               |
| Power Dissipation <sup>A</sup>                 | $P_{DSM}$        | $T_A=25^\circ\text{C}$  | 3.1              |
|  |                  | $T_A=70^\circ\text{C}$  | 2                |
| Junction and Storage Temperature Range         | $T_J, T_{STG}$   | -55 to 150              | $^\circ\text{C}$ |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ          | Max | Units              |
|--|-----------------|--------------|-----|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 30           | 40  | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A,D</sup> |                 | Steady-State | 60  | 75                 |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 3.5          | 4.2 | $^\circ\text{C/W}$ |

Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

| Symbol                      | Parameter                             | Conditions  | Min  | Typ        | Max        | Units            |
|-----------------------------|---------------------------------------|---|------|------------|------------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |   |      |            |            |                  |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=250\mu\text{A}$ , $V_{GS}=0\text{V}$   | 30   | 36         |            | V                |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=30\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                  |      |            | 1<br>5     | $\mu\text{A}$    |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 20\text{V}$  |      |            | 10         | $\mu\text{A}$    |
| $V_{GS(th)}$                | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$  | 1.35 | 1.85       | 2.35       | V                |
| $I_{D(ON)}$                 | On state drain current                | $V_{GS}=10\text{V}$ , $V_{DS}=5\text{V}$  | 130  |            |            | A                |
| $R_{DS(ON)}$                | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}$ , $I_D=18\text{A}$<br>$T_J=125^\circ\text{C}$                   |      | 4.5<br>7.2 | 5.5<br>8.8 | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=4.5\text{V}$ , $I_D=14\text{A}$   |      | 5.8        | 8          |                  |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=5\text{V}$ , $I_D=18\text{A}$   |      | 75         |            | S                |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}$ , $V_{GS}=0\text{V}$  |      | 0.7        | 1          | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |   |      |            | 35         | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |   |      |            |            |                  |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}$ , $V_{DS}=15\text{V}$ , $f=1\text{MHz}$                          | 1410 | 1765       | 2120       | pF               |
| $C_{oss}$                   | Output Capacitance                    |   | 195  | 283        | 370        | pF               |
| $C_{riss}$                  | Reverse Transfer Capacitance          |   | 90   | 155        | 220        | pF               |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $f=1\text{MHz}$                           | 1.3  | 2.6        | 3.9        | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |   |      |            |            |                  |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=10\text{V}$ , $V_{DS}=15\text{V}$ , $I_D=18\text{A}$                        | 26   | 33         | 40         | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |   | 12.5 | 16         | 19.5       | nC               |
| $Q_{gs}$                    | Gate Source Charge                    |   |      | 5.2        |            | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |   |      | 6.2        |            | nC               |
| $t_{D(on)}$                 | Turn-On DelayTime                     | $V_{GS}=10\text{V}$ , $V_{DS}=15\text{V}$ , $R_L=0.83\Omega$ ,<br>$R_{GEN}=3\Omega$ |      | 6          |            | ns               |
| $t_r$                       | Turn-On Rise Time                     |   |      | 4          |            | ns               |
| $t_{D(off)}$                | Turn-Off DelayTime                    |   |      | 33         |            | ns               |
| $t_f$                       | Turn-Off Fall Time                    |   |      | 7.5        |            | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=18\text{A}$ , $dI/dt=500\text{A}/\mu\text{s}$                                  | 9.5  | 12.3       | 15         | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=18\text{A}$ , $dI/dt=500\text{A}/\mu\text{s}$                                  | 20   | 25         | 30         | nC               |

A. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{DSM}$  is based on  $R_{\theta JA}$   $t \leq 10\text{s}$  value and the maximum allowed junction temperature of  $150^\circ\text{C}$ . The value in any given application depends on the user's specific board design, and the maximum temperature of  $150^\circ\text{C}$  may be used if the PCB allows it.

B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=150^\circ\text{C}$ . Ratings are based on low frequency and duty cycles to keep initial  $T_J=25^\circ\text{C}$ .

D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ .

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

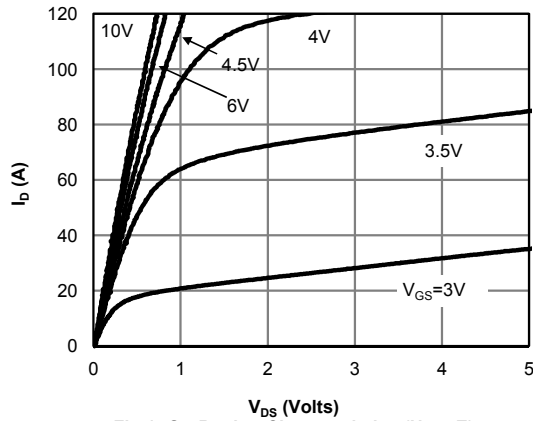


Fig 1: On-Region Characteristics (Note E)

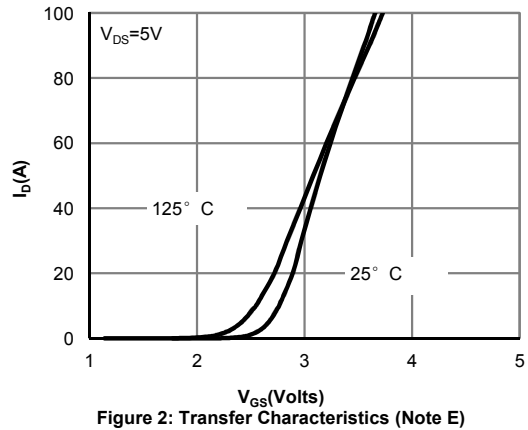


Figure 2: Transfer Characteristics (Note E)

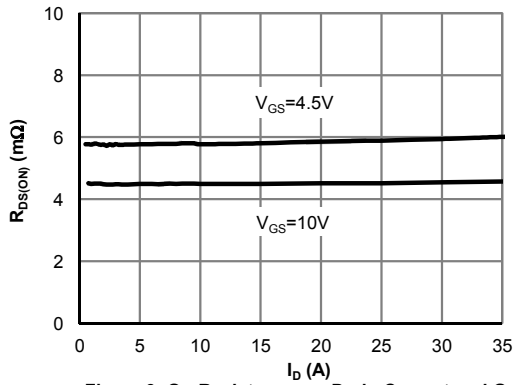


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

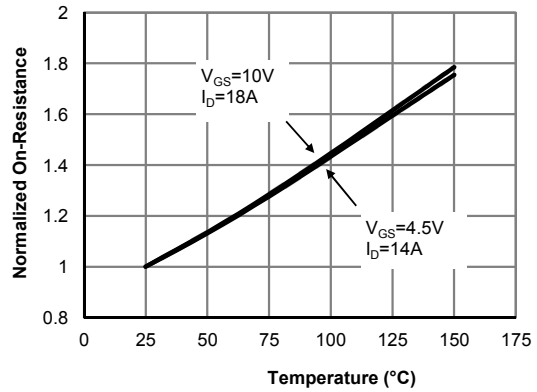


Figure 4: On-Resistance vs. Junction Temperature (Note E)

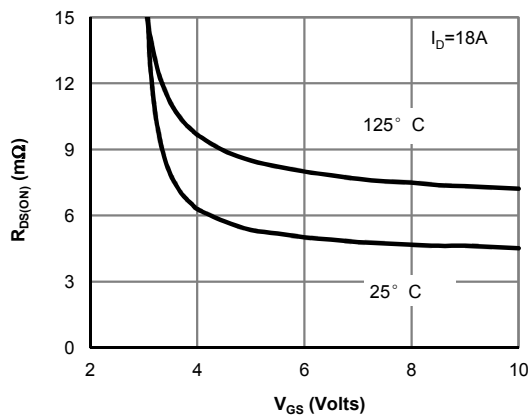


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

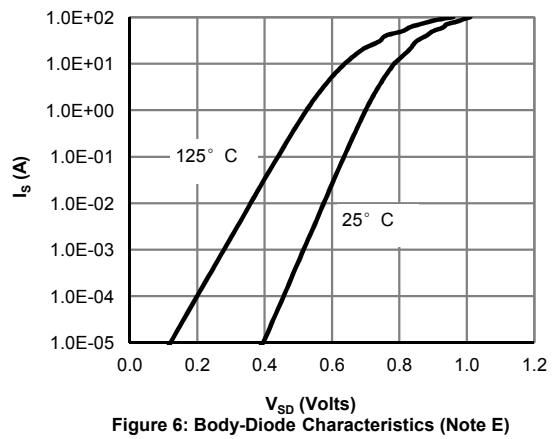


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

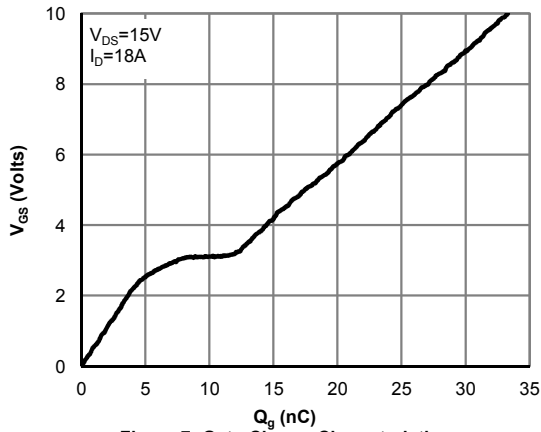


Figure 7: Gate-Charge Characteristics

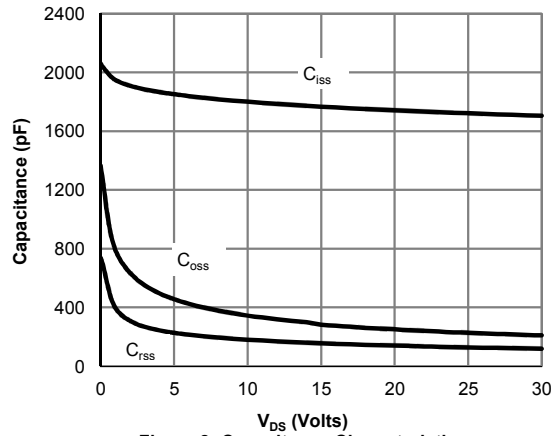


Figure 8: Capacitance Characteristics

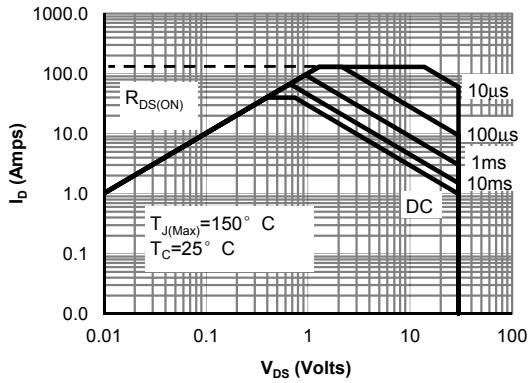


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

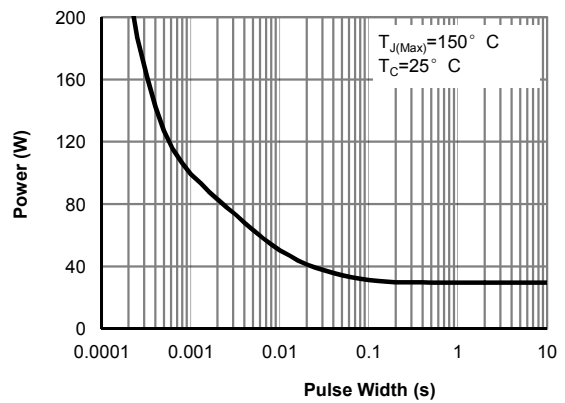


Figure 10: Single Pulse Power Rating Junction-to-Ca (Note F)

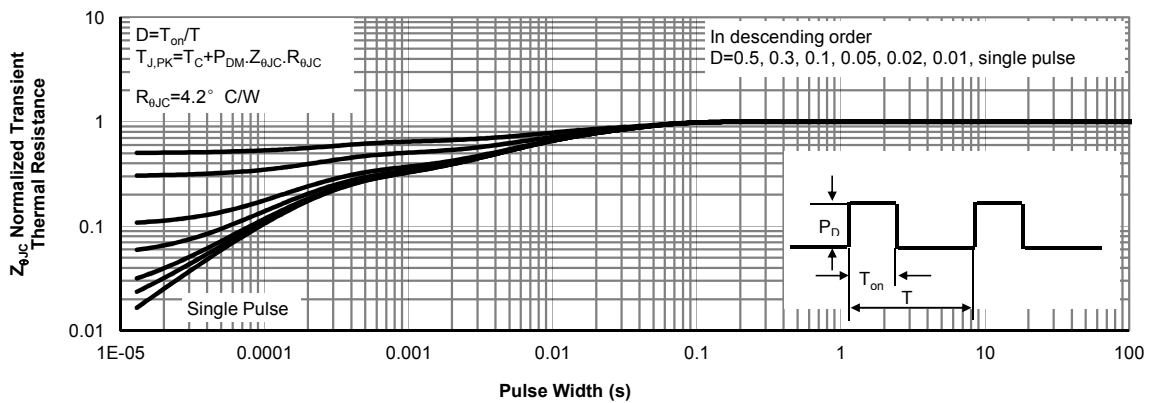


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

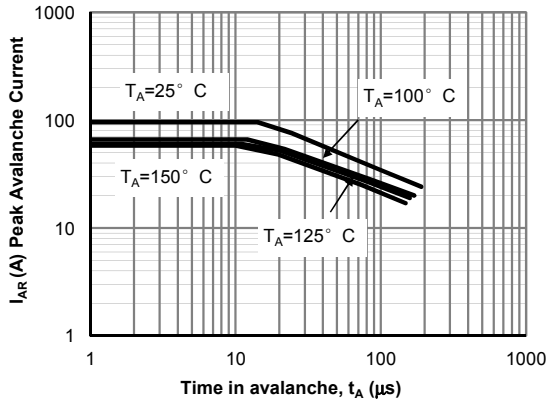


Figure 12: Single Pulse Avalanche capability (Note C)

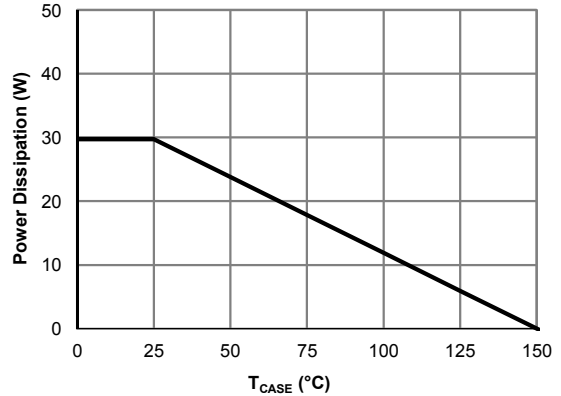


Figure 13: Power De-rating (Note F)

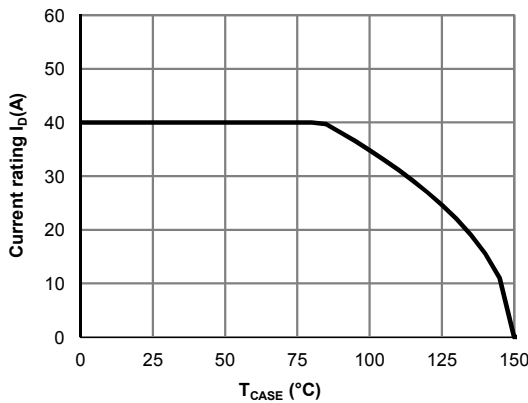


Figure 14: Current De-rating (Note F)

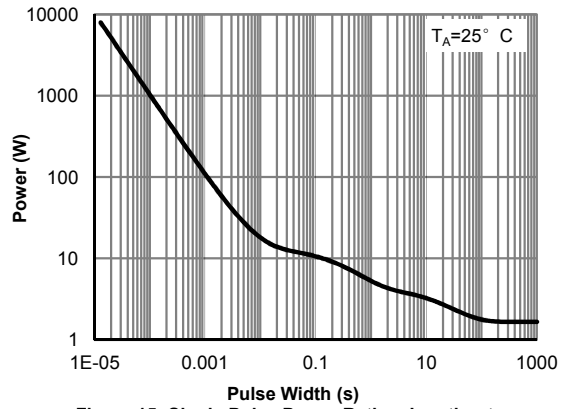


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

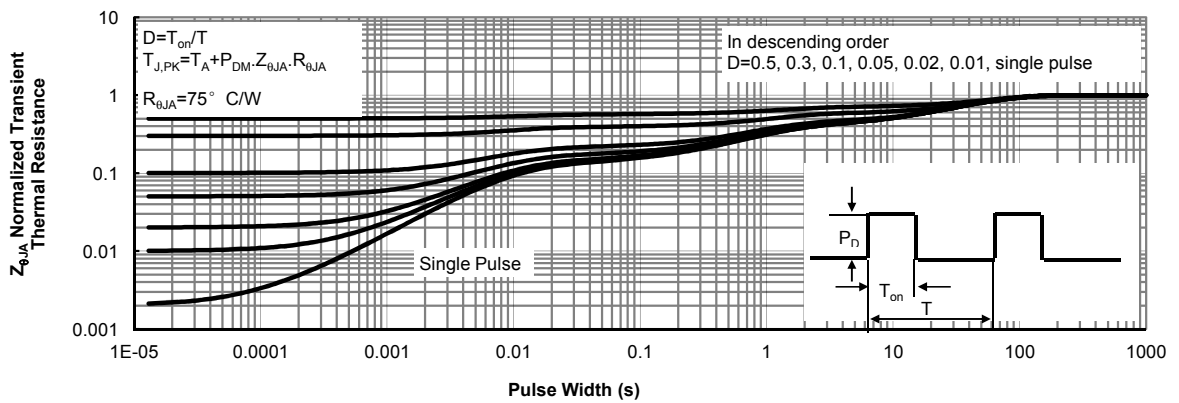
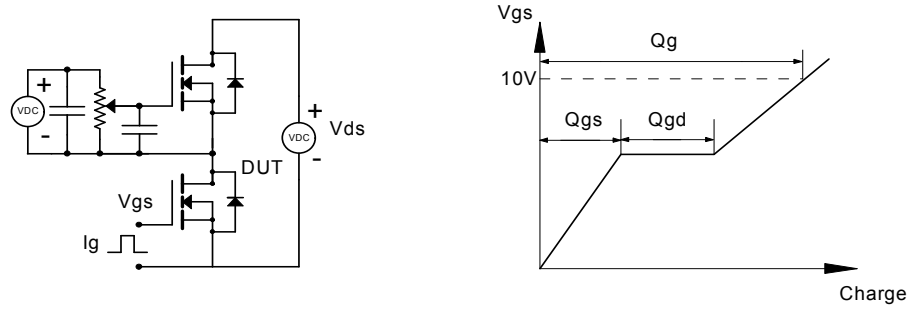
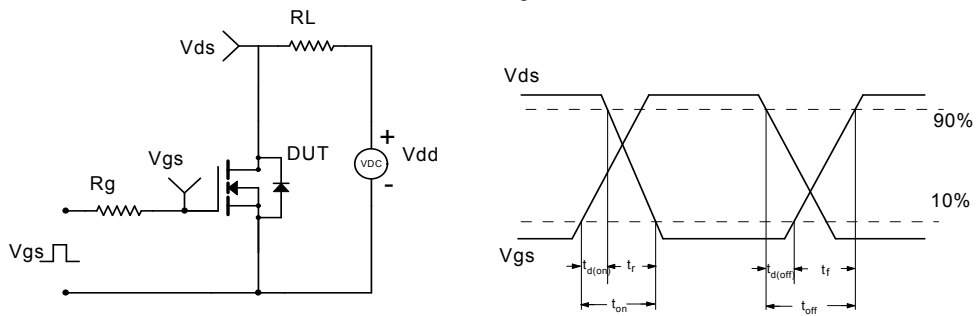


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

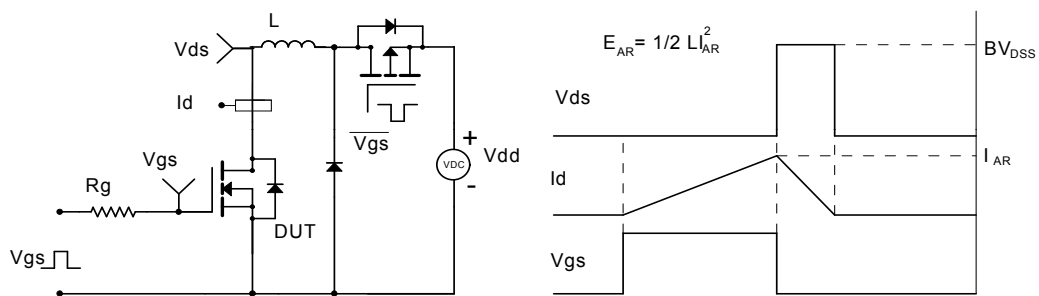
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

